# MSKSEMI 美森科













**ESD** 

TV

TSS

MOV

GDT

PIFD

AZ5123-01H-MS

**Product specification** 





#### **FEATURES**

- 80W peak pulse power per line (tP = 8/20µs)
- SOD-523 package
- Replacement for MLV(0603)
- Bidirectional configurations
- Protects one power or I/O port
- Low clamping voltage
- RoHS compliant
- Transient protection for data lines to IEC 61000-4-2(ESD)±30kV(air), ±30kV(contact); IEC 61000-4-4 (EFT) 40A (5/50ns)

## **Applications**

- Cellular phones
- Portable devices
- Digital cameras
- Power supplies

## **Mechanical Characteristics**

- Lead finish:100% matte Sn(Tin)
- Mounting position: Any
- Qualified max reflow temperature:260 ℃
- Device meets MSL 1 requirements
- Pure tin plating: 7 ~ 17 um
- Pin flatness: ≤3mil

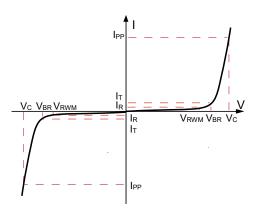
#### **Reference News**

PACKAGE OUTLINE	PIN CONFIGURATION	Marking
WHI HERMAN	Pin1 Pin2	<b>B</b> 5∞
SOD-523		



## **Electronics Parameter**

Symbol	Parameter		
VRWM	Peak Reverse Working Voltage		
<b>l</b> R	Reverse Leakage Current @ VRWM		
V <sub>BR</sub>	Breakdown Voltage @ I⊤		
lτ	Test Current		
IPP	Maximum Reverse Peak Pulse Current		
Vc	Clamping Voltage @ IPP		
Ppp	Peak Pulse Power		
Cı	Junction Capacitance		
F	Forward Current		
VF	Forward Voltage @ IF		



# Electrical characteristics per line@25 $^{\circ}$ C (unless otherwisespecified)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Peak Reverse Working Voltage	VRWM			3.3		V
Breakdown Voltage	VBR	h = 1mA	4.8		6.8	V
Reverse Leakage Current	<b>I</b> R	V <sub>RWM</sub> = 5V T=25°C			1.0	μA
Clamping Voltage <sup>1)</sup>	V <sub>C</sub>	TLP = 16A, t = 100ns		9.0		V
Dynamic resistance <sup>1)</sup>	R <sub>DYN</sub>			0.15		Ω
Clamping Voltage <sup>2)</sup>	Vc	IPP=8A		8	10	V
Junction Capacitance	C	V <sub>R</sub> =0V f = 1MHz		33		pF

#### Notes:

- 1. TLP parameter:  $Z_0$ =50 $\Omega$ ,  $t_p$ =100ns,  $t_r$ =2ns, averaging window from 60ns to 80ns.  $R_{DYN}$  is calculated from 4A to 16A.
- 2. Non-repetitive current pulse, according to IEC61000-4-5.

## Absolute maximum rating@25℃

Rating	Symbol	Value	Unit
Peak Pulse Power (t <sub>P</sub> =8/20µs)	P <sub>pp</sub>	80	W
Operating Temperature	TJ	-55 to +150	°C
Storage Temperature	Тѕтс	-55 to +150	°C



## **TypicalCharacteristics**



Fig 1. Pulse Waveform

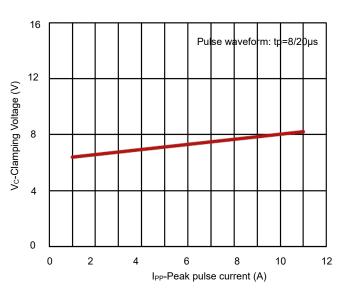


Fig 3. Clamping voltage vs. Peak pulse current

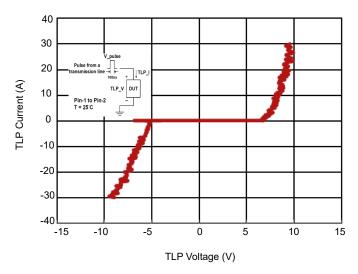


Fig 5. TLP Measurement

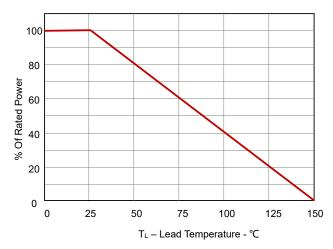


Fig 2. Power Derating Curve

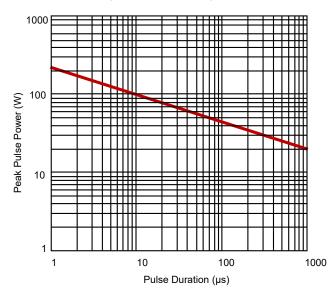


Fig 4. Non Repetitive Peak Pulse Power vs. Pulse time

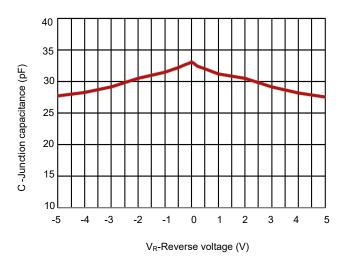


Fig 6. Capacitance vs. Reveres voltage



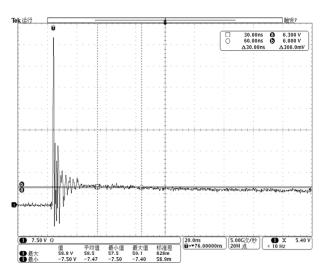


Fig7.ESD Clamping voltage

(IEC61000-4-2 +8kV contact)

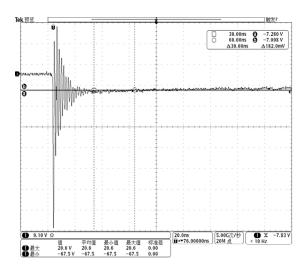
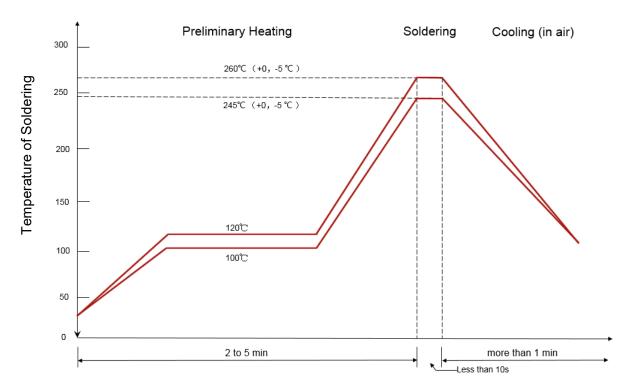


Fig8.ESD Clamping voltage

(IEC61000-4-2-8kV contact)

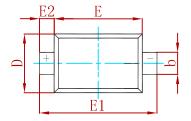
#### **Solder Reflow Recommendation**

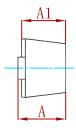


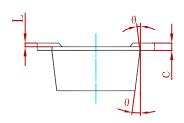
Remark: Pb free for 260°C; Pb for 245°C.



#### PACKAGE MECHANICAL DATA

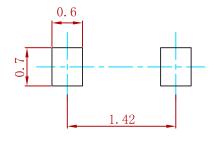






Symbol	Dimensions In Millimeters		Dimension	s In Inches
Syllibol	Min	Max	Min	Max
Α	0.510	0.770	0.020	0.031
A1	0.500	0.700	0.020	0.028
b	0.250	0.350	0.010	0.014
С	0.080	0.150	0.003	0.006
D	0.750	0.850	0.030	0.033
E	1.100	1.300	0.043	0.051
E1	1.500	1.700	0.059	0.067
E2	0.200 REF		0.008 REF	
L	0.010	0.070	0.001	0.003
θ	7° REF 7° REF		REF	

## **Suggested Pad Layout**



#### Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

## **REEL SPECIFICATION**

P/N	PKG	QTY
AZ5123-01H-MS	SOD-523	3000



#### **Attention**

- Any and all MSKSEMI Semiconductor products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your MSKSEMI Semiconductor representative nearest you before using any MSKSEMI Semiconductor products described or contained herein in such applications.
- MSKSEMI Semiconductor assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all MSKSEMI Semiconductor products described or contained herein.
- Specifications of any and all MSKSEMI Semiconductor products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer'sproducts or equipment.
- MSKSEMI Semiconductor. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with someprobability. It is possiblethat these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits anderror prevention circuitsfor safedesign, redundant design, and structural design.
- In the event that any or all MSKSEMI Semiconductor products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from theauthorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of MSKSEMI Semiconductor.
- Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. MSKSEMI Semiconductor believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. Whendesigning equipment, refer to the "Delivery Specification" for the MSKSEMI Semiconductor productthat you intend to use.